

IN THE SPECIFICATION

Please amend the specification as follows:

Replace the paragraph spanning pages 1-2, between page 1, line 24, and page 2, line 20 of the specification with the following:

~~This~~ In accordance with one embodiment, this object is achieved by ~~the characterizing features of the mutually parallel main claims 1, 8, 9, and 10. According to claim 1, the object is achieved by the following process steps: the current through the sensor is switched off for a short period during a first half wave and a first test value is determined, then the current through the sensor is switched off for a short period during a second half wave having a different polarity and a second test value is determined, whereupon an average is formed of the two test values, and the zero point is determined by means of the average value in that a weighted sum of the average value and the value assumed up to that time for the sensor zero point (Vx) is formed. A reliable determination of the zero point, also denoted sensor zero point hereinafter, is possible when the current in the sensor itself is~~

known by some other method. For this purpose, the current supply is switched off or interrupted by deactivation of all power transistors during operation for a short period not visible to the human eye, for example during the positive current half wave. A current scanning void is thus created. It can be achieved thereby that the current in the sensor drops to zero within a few microseconds. A suitable time period is, for example, 100 μ s. This time period is sufficiently long for reliably bringing the current in the sensor to zero and in addition renders possible a substantial decay of response phenomena in the filters of the current measuring circuit. A full response, however, takes infinitely long, so that now only residual values of an earlier measurement are active. A first test value is now determined. To compensate for the effect of residual values of earlier measurements, the switch-off action is repeated for the same duration in one of the subsequent half waves having a different polarity. The residual value now has a negative sign. A second test value is thus determined. In both cases, however, the sensor zero point is present as a constant component, so that an average value of the two supplies an improved estimation for the zero point

error, also denoted deviation from zero hereinafter, as a sensor offset or offset error. Once the sensor offset has been finally and correctly determined, no further corrections are provided.

Replace the paragraph spanning pages 3-4, between page 3, line 25, and page 4, line 4 of the specification with the following:

Fig. 2 shows a voltage signal 5 of a sensor which is a representation of the lamp current 1 and which is symmetrical with respect to a zero line 6. The zero line 6, also denoted real zero line below, passes through the zero point V_0 of the sensor, also denoted real zero point V_0 of the sensor below. This means that the line through the zero point V_0 represents an output signal of the sensor that is actually obtained for a zero current value. At moment t_1 , the voltage 5 within the sensor starts to drop exponentially from a value V_2 to a value V_3 owing to the influence of filters and bandwidth limiters, which value V_3 is reached after a period of Δt . At moment t_2 , the voltage 5 within the sensor starts ~~dropping~~ rising exponentially from a value $-V_2$ to a value $-V_3$, which value $-V_3$ is reached after a period of Δt . The values V_3 and $-V_3$ represent residual values of former measured values.

Assuming that a value already placed in a memory or stored on the basis of an earlier measurement, also denoted assumed zero point below, is identical to V_0 , the two values V_3 and $-V_3$ will exactly cancel each other out. A correction of the zero point is not necessary. The absolute values of the residual levels V_3 and $-V_3$ are identical for the two half cycles 3 and 4.

Replace the paragraph on page 4, between lines 13-28 of the specification with the following:

Fig. 4 shows the voltage signal 15 of a sensor with the real zero line 6 and the assumed zero line 7. During the first half cycle 3, the voltage 15 starts dropping exponentially from a value V_5 to a value V_6 at moment t_1 . The value V_6 is reached after a time duration of Δt just before the lamp current 1 is switched on again, the distance of V_6 to the assumed zero line 7 being measured and stored. In the second, negative half cycle 4, the voltage 15 starts ~~dropping~~ rising exponentially from a value $-V_8$ to a value $-V_7$ at moment t_2 . This value $-V_7$ is reached after a time duration of t just before the lamp current is switched on again, the distance of $-V_7$ to the assumed zero line 7 also being measured and stored. The

distances $V_x - V_6$ and $V_x - (-V_7)$ are added together, divided by two, possibly weighted, and added to the value V_x . The resulting new value for V_x now lies closer to the correct value V_0 than the previous value for V_x . When the procedure is repeated several times, the difference between V_0 and the value of V_x becomes increasingly smaller until the correct sensor zero point has been determined. This procedure is also denoted the determination, definition, or compensation of the sensor zero value V_0 or the determination of the deviation. A single measuring cycle suffices in the case in which the sensor signal has already become fully stabilized at the moment of measurement.